

HEXFET® Power MOSFET

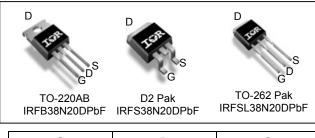
# **Applications**

- High frequency DC-DC converters
- Plasma Display Panel

# **Benefits**

- Low Gate-to-Drain Charge to Reduce Switching Losses
- Fully Characterized Capacitance Including Effective C<sub>OSS</sub> to Simplify Design, (See App. Note AN1001)
- Fully Characterized Avalanche Voltage and Current
- Lead-Free

TIEXI ET TOWEI MOSI E						
Key Parameters						
V <sub>DS</sub>	200	V				
V <sub>DS(Avalanche)</sub> min.	260	V				
R <sub>DS(on)</sub> max @ 10V	54	mΩ				
T」max	175	°C				



G	D	S	
Gate	Drain	Source	

Daga want number	Dookses Tyres	Standard Pack	Oudenskie Best Neusker		
Base part number	Package Type	Form	Quantity	Orderable Part Number	
IRFB38N20DPbF	TO-220	Tube	50	IRFB38N20DPbF	
IRFSL38N20DPbF	TO-262	Tube	50	IRFSL38N20DPbF	
IDEC20NOODDLE	DO Dale	Tube	50	IRFS38N20DPbF	
IRFS38N20DPbF	D2-Pak	Tape and Reel Left	800	IRFS38N20DTRLPbF	

**Absolute Maximum Ratings** 

Symbol	Symbol Parameter		Units
I <sub>D</sub> @ T <sub>C</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V ⑦	43*	
I <sub>D</sub> @ T <sub>C</sub> = 100°C	Continuous Drain Current, V <sub>GS</sub> @ 10V ⑦	30*	A
I <sub>DM</sub>	Pulsed Drain Current ①	180	
P <sub>D</sub> @T <sub>A</sub> = 25°C	Maximum Power Dissipation ⑦	3.8	W
P <sub>D</sub> @T <sub>C</sub> = 25°C	Maximum Power Dissipation ⊘	300*	W
	Linear Derating Factor⊘	2.0*	W/°C
$V_{GS}$	Gate-to-Source Voltage	± 30	V
dv/dt	Peak Diode Recovery dv/dt③	9.5	V/ns
$T_J$	Operating Junction and	-55 to + 175	
$T_{STG}$	Storage Temperature Range		°C
	Soldering Temperature, for 10 seconds (1.6mm from case)	300	
	Mounting torque, 6-32 or M3 screw®	10 lbf•in (1.1N•m)	

# **Thermal Resistance**

Symbol	Parameter	Тур.	Max.	Units
$R_{\theta JC}$	Junction-to-Case		0.47*	
$R_{\theta CS}$	Case-to-Sink, Flat, Greased Surface®	0.50		°0.04/
$R_{\theta JA}$	Junction-to-Ambient ®		62	°C/W
$R_{\theta JA}$	Junction-to-Ambient ( PCB Mount, steady state) ⑦		40	1

<sup>\*</sup>  $R_{\theta JC}$  (end of life) for D2Pak and TO-262 = 0.50°C/W. This is the maximum measured value after 1000 temperature cycles from -55 to 150°C and is accounted for by the physical wear out of the die attach medium.

Notes ① through ⑦ are on page 2.



# Static @ T<sub>J</sub> = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
V <sub>(BR)DSS</sub>	Drain-to-Source Breakdown Voltage	200			V	$V_{GS} = 0V, I_D = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_J$	Breakdown Voltage Temp. Coefficient		0.22		V/°C	Reference to 25°C, I <sub>D</sub> = 1mA
R <sub>DS(on)</sub>	Static Drain-to-Source On-Resistance			0.054	Ω	V <sub>GS</sub> = 10V, I <sub>D</sub> = 26A ④
$V_{GS(th)}$	Gate Threshold Voltage	3.0		5.0	V	$V_{DS} = V_{GS}$ , $I_D = 250\mu A$
	Drain to Source Leekage Current			25		V <sub>DS</sub> =200 V, V <sub>GS</sub> = 0V
I <sub>DSS</sub>	Drain-to-Source Leakage Current			250	μA	$V_{DS} = 160V, V_{GS} = 0V, T_{J} = 150^{\circ}C$
I <sub>GSS</sub>	Gate-to-Source Forward Leakage			100	- Λ	$V_{GS} = 30V$
	Gate-to-Source Reverse Leakage			-100	nA	$V_{GS} = -30V$

# Dynamic @ T<sub>J</sub> = 25°C (unless otherwise specified)

gfs	Forward Trans conductance	17			S	$V_{DS} = 50V, I_{D} = 26A$
$Q_g$	Total Gate Charge		60	91		I <sub>D</sub> = 26A
$Q_{gs}$	Gate-to-Source Charge		17	25	nC	V <sub>DS</sub> = 100V
$Q_{gd}$	Gate-to-Drain Charge		28	42		V <sub>GS</sub> = 10V ④
$t_{d(on)}$	Turn-On Delay Time		16			V <sub>DD</sub> = 100V
t <sub>r</sub>	Rise Time		95		ns	I <sub>D</sub> =26A
$t_{d(off)}$	Turn-Off Delay Time		29		115	$R_G = 2.5\Omega$
t <sub>f</sub>	Fall Time		47			V <sub>GS</sub> = 10V ④
C <sub>iss</sub>	Input Capacitance		2900			$V_{GS} = 0V$
$C_{oss}$	Output Capacitance		450			V <sub>DS</sub> = 25V
$C_{rss}$	Reverse Transfer Capacitance		73		ne	f = 1.0MHz
$C_{oss}$	Output Capacitance		3550		pF	$V_{GS} = 0V, V_{DS} = 1.0V f = 1.0MHz$
Coss	Output Capacitance		180		-	$V_{GS} = 0V$ , $V_{DS} = 160V$ $f = 1.0MHz$
Coss eff.	Effective Output Capacitance		380			$V_{GS} = 0V, V_{DS} = 0V \text{ to } 160V$

# **Avalanche Characteristics**

	Parameter		Min.	Тур.	Max.	Units	
E <sub>AS</sub>	Single Pulse Avalanche Energy 26				460	mJ	
I <sub>AR</sub>	Avalanche Current ①				26	Α	
E <sub>AR</sub>	Repetitive Avalanche Energy ①			390		mJ	
V <sub>DS</sub> (Avalanche)	Repetitive Avalanche Voltage①		260			V	

## **Diode Characteristics**

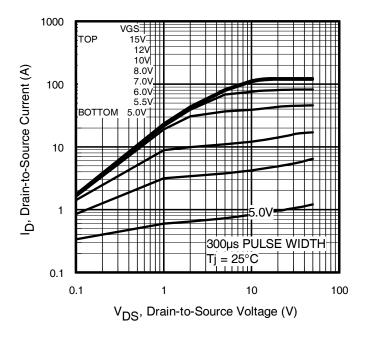
blode Characteristics							
	Parameter	Min.	Тур.	Max.	Units	Conditions	
Is	Continuous Source Current (Body Diode)			44		MOSFET symbol showing the	
I <sub>SM</sub>	Pulsed Source Current (Body Diode) ①⑥			180		integral reverse p-n junction diode.	
$V_{SD}$	Diode Forward Voltage			1.5	V	$T_J = 25^{\circ}C, I_S = 26A, V_{GS} = 0V $ ④	
t <sub>rr</sub>	Reverse Recovery Time		160	240	ns	$T_J = 25^{\circ}C$ , $I_F = 26A$	
$Q_{rr}$	Reverse Recovery Charge		1.3	2.0	μС	di/dt = 100A/µs ④	
t <sub>on</sub>	Forward Turn-On Time	Intrinsio	Intrinsic turn-on time is negligible (turn-on is dominated by L <sub>S</sub> +L <sub>D</sub> )				

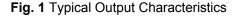
# Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature.
- $\odot$  starting T<sub>J</sub> = 25°C, L = 1.3mH, R<sub>G</sub> = 25 $\Omega$ , I<sub>AS</sub> = 26A.
- $\label{eq:local_local_local_local} \ensuremath{\Im} \quad I_{SD} \leq 26 A, \ di/dt \leq 390 A/\mu s, \ V_{DD} \leq V_{(BR)DSS}, \ T_J \leq 175^{\circ} C.$
- 4 Pulse width  $\leq 300 \mu s$ ; duty cycle  $\leq 2\%$ .
- $\odot$  C<sub>oss</sub> eff. is a fixed capacitance that gives the same charging time as C<sub>oss</sub> while V<sub>DS</sub> is rising from 0 to 80% V<sub>DSS</sub>.
- © This is only applied to TO-220AB package.
- When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note #AN-994.

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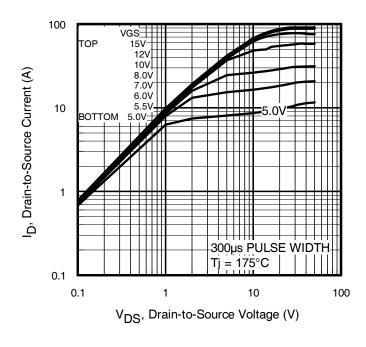


Fig. 2 Typical Output Characteristics

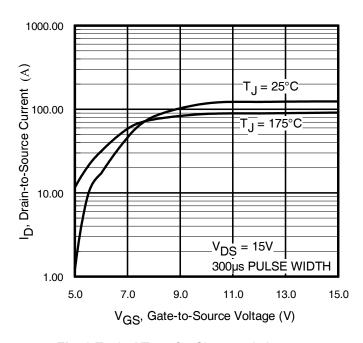
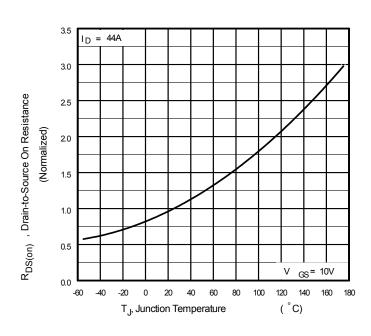
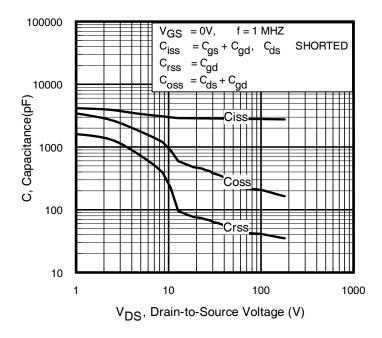


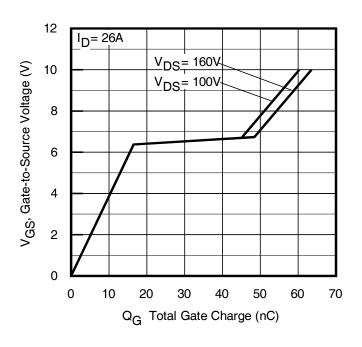
Fig. 3 Typical Transfer Characteristics



**Fig. 4** Normalized On-Resistance vs. Temperature



**Fig 5.** Typical Capacitance vs. Drain-to-Source Voltage



**Fig 6.** Typical Gate Charge vs. Gate-to-Source Voltage

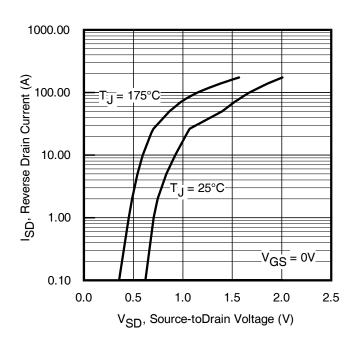


Fig. 7 Typical Source-to-Drain Diode Forward Voltage

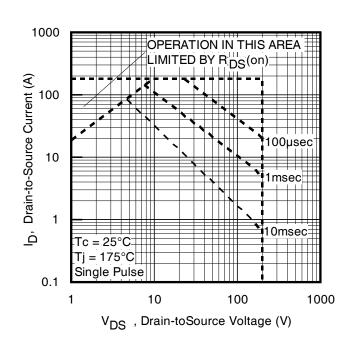


Fig 8. Maximum Safe Operating Area

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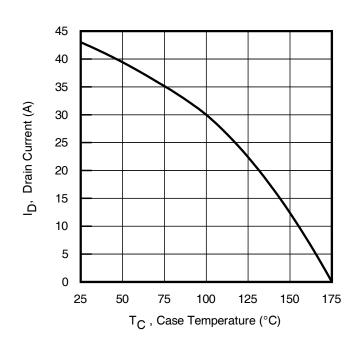


Fig 9. Maximum Drain Current vs. Case Temperature

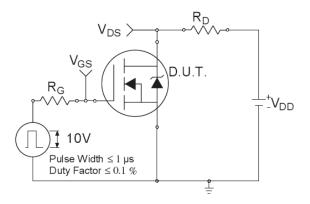


Fig 10a. Switching Time Test Circuit

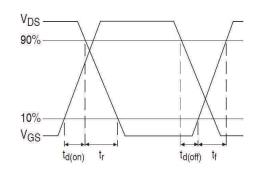


Fig 10b. Switching Time Waveforms

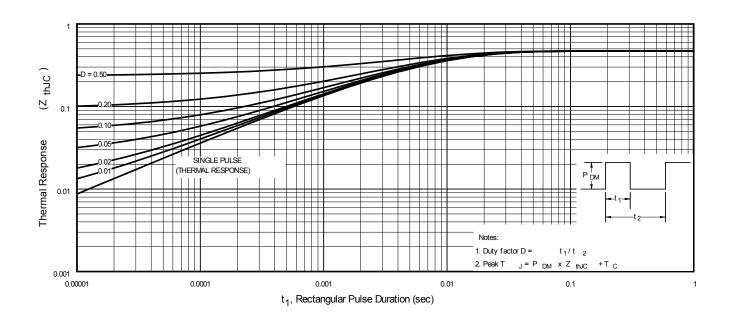


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

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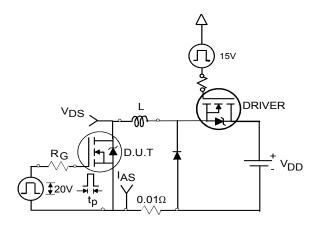


Fig 12a. Unclamped Inductive Test Circuit

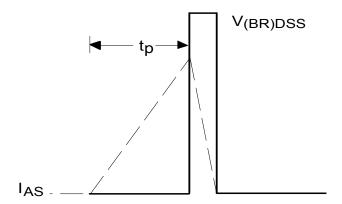
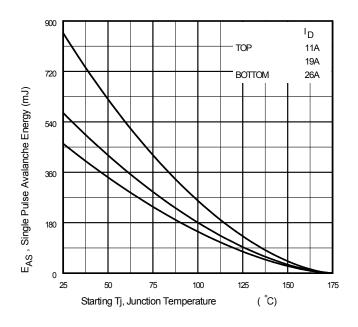


Fig 12b. Unclamped Inductive Waveforms



**Fig 12c.** Maximum Avalanche Energy vs. Drain Current

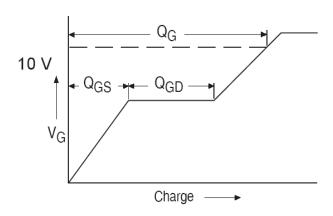


Fig 13a. Gate Charge Waveform

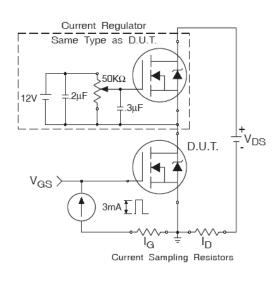
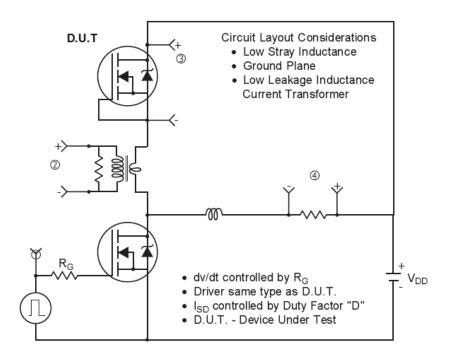


Fig 13b. Gate Charge Test Circuit



# Peak Diode Recovery dv/dt Test Circuit



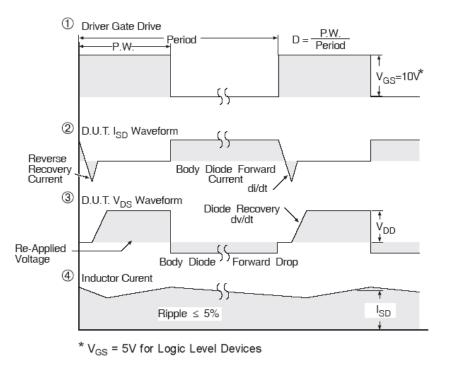
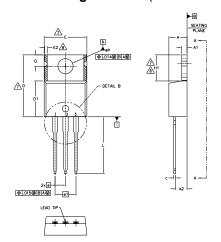
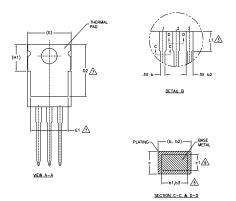


Fig 14. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs



# TO-220AB Package Outline (Dimensions are shown in millimeters (inches))





### NOTES:

- DIMENSIONING AND TOLERANCING AS PER ASME Y14.5 M- 1994. 1.-
- DIMENSIONS ARE SHOWN IN INCHES [MILLIMETERS]
- LEAD DIMENSION AND FINISH UNCONTROLLED IN L1.
  DIMENSION D, D1 & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH
  SHALL NOT EXCEED .005" (0.127) PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
- DIMENSION 61, 63 & c1 APPLY TO BASE METAL ONLY.
- CONTROLLING DIMENSION: INCHES.
- THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSIONS E,H1,D2 & E1
- DIMENSION E2 X H1 DEFINE A ZONE WHERE STAMPING AND SINGULATION IRREGULARITIES ARE ALLOWED.
- OUTLINE CONFORMS TO JEDEC TO-220, EXCEPT A2 (max.) AND D2 (min.) WHERE DIMENSIONS ARE DERIVED FROM THE ACTUAL PACKAGE OUTLINE.

SYMB	OL	MILLIM	ETERS	INC	CHES	
		MIN.	MAX.	MIN.	MAX.	NOTES
Α		3.56	4.83	.140	.190	
A1		1.14	1.40	.045	.055	
A2		2.03	2.92	.080	.115	
b		0.38	1.01	.015	.040	
b1		0.38	0.97	.015	.038	5
b2		1.14	1.78	.045	.070	
b3		1,14	1.73	.045	.068	5
С		0.36	0.61	.014	.024	
c1		0.36	0.56	.014	.022	5
D		14.22	16.51	.560	.650	4
D1		8.38	9.02	.330	.355	
D2		11.68	12.88	.460	.507	7
E		9.65	10.67	.380	.420	4,7
E1		6.86	8.89	.270	.350	7
E2		-	0.76	-	.030	8
е		2.54	BSC	.100	BSC	
e1		5.08	BSC	.200	BSC	
H1		5.84	6.86	.230	.270	7,8
L		12.70	14.73	.500	.580	
L1		3.56	4.06	.140	.160	3
ØΡ		3.54	4.08	.139	.161	
Q		2.54	3.42	.100	.135	

## LEAD ASSIGNMENTS

## HEXFET

1.- GATE 2.- DRAIN 3.- SOURCE

### IGBTs, CoPACK

1.- GATE 2.- COLLECTOR 3.- EMITTER

## DIODES

1.- ANODE 2.- CATHODE 3.- ANODE

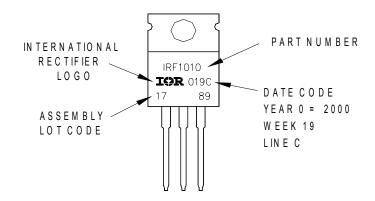
# **TO-220AB Part Marking Information**

EXAMPLE: THIS IS AN IRF1010

LOT CODE 1789

ASSEMBLED ON WW 19,2000 IN THE ASSEMBLY LINE "C"

Note: "P" in assembly line position indicates "Lead - Free'



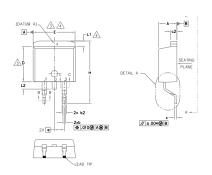
TO-220AB packages are not recommended for Surface Mount Application.

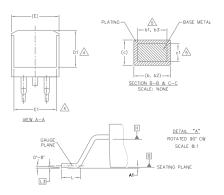
## Notes:

- 1. For an Automotive Qualified version of this part please see http://www.infineon.com/product-info/auto/
- 2. For the most current drawing please refer to Infineon website at http://www.infineon.com/package/



# D2-Pak (TO-263AB) Package Outline (Dimensions are shown in millimeters (inches))





NOTES:

1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994

2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].

AT THE OUTMOST EXTREMES OF THE PLASTIC BODY AT DATUM H.

4. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSION E, L1, D1 & E1.

5. DIMENSION 61, 63 AND c1 APPLY TO BASE METAL ONLY.

6. DATUM A & B TO BE DETERMINED AT DATUM PLANE H.

7. CONTROLLING DIMENSION: INCH.

8. OUTLINE CONFORMS TO JEDEC OUTLINE TO-263AB.

S Y M	DIMENSIONS					
В	MILLIM	ETERS	INC	HES	0 T E S	
O L	MIN.	MAX.	MIN.	MAX.	S	
А	4.06	4.83	.160	.190		
A1	0.00	0.254	.000	.010		
b	0.51	0.99	.020	.039		
Ь1	0.51	0.89	.020	.035	5	
b2	1.14	1.78	.045	.070		
b3	1.14	1.73	.045	.068	5	
С	0.38	0.74	.015	.029		
с1	0.38	0.58	.015	.023	5	
c2	1.14	1.65	.045	.065		
D	8.38	9.65	.330	.380	3	
D1	6.86	_	.270	_	4	
E	9.65	10.67	.380	.420	3,4	
E1	6.22	_	.245	_	4	
е	2.54	BSC	.100	.100 BSC		
Н	14.61	15.88	.575	.625		
L	1.78	2.79	.070	.110		
L1	_	1.68	_	.066	4	
L2	_	1.78	_	.070		
L3	0.25	BSC	.010	BSC		

## LEAD ASSIGNMENTS

DIODES

1.- ANODE (TWO DIE) / OPEN (ONE DIE)

2, 4.- CATHODE 3.- ANODE

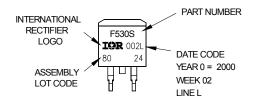
IGBTs, CoPACK 2, 4.- COLLECTOR 3.- EMITTER

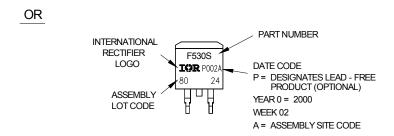
# D2-Pak (TO-263AB) Part Marking Information

EXAMPLE: THIS IS AN IRF530S WITH LOT CODE 8024

ASSEMBLED ON WW 02, 2000 IN THE ASSEMBLY LINE "L"

Note: "P" in assembly line position indicates "Lead - Free"

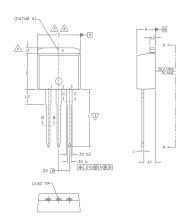


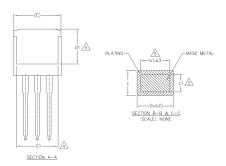


- 1. For an Automotive Qualified version of this part please see <a href="http://www.infineon.com/product-info/auto/">http://www.infineon.com/product-info/auto/</a>
- 2. For the most current drawing please refer to Infineon website at http://www.infineon.com/package/



# TO-262 Package Outline (Dimensions are shown in millimeters (inches)





#### NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].

O.127 [.005"] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.

4. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSION E, L1, D1 & E1.

5. DIMENSION 61 AND c1 APPLY TO BASE METAL ONLY.

- 6. CONTROLLING DIMENSION: INCH.
- 7.— OUTLINE CONFORM TO JEDEC TO-262 EXCEPT A1(mox.), b(min.) AND D1(min.) WHERE DIMENSIONS DERIVED THE ACTUAL PACKAGE OUTLINE.

### LEAD ASSIGNMENTS

### IGBTs, CoPACK

1.- GATE 2.- COLLECTOR 3.- EMITTER

4.- COLLECTOR

<u>HEXFET</u>

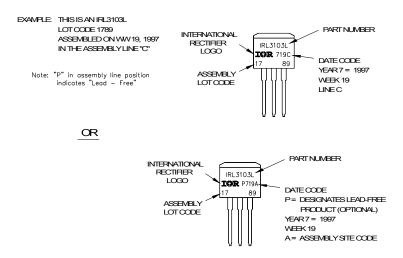
1.- GATE 1.- ANODE (TWO DIE) / OPEN (ONE DIE)

2.- DRAIN 2, 4.- CATHODE 3.- SOURCE 3.- ANODE

4.- DRAIN

S Y M	DIMENSIONS				
В	MILLIM	ETERS	INC	HES	O T E S
0 L	MIN.	MAX.	MIN.	MAX.	S
Α	4.06	4.83	.160	.190	
A1	2.03	3.02	.080	.119	
b	0.51	0.99	.020	.039	
b1	0.51	0.89	.020	.035	5
b2	1.14	1.78	.045	.070	
ь3	1.14	1.73	.045	.068	5
С	0.38	0.74	.015	.029	
c1	0.38	0.58	.015	.023	5
c2	1.14	1.65	.045	.065	
D	8.38	9.65	.330	.380	3
D1	6.86	_	.270	_	4
E	9.65	10.67	.380	.420	3,4
E1	6.22	_	.245		4
е	2.54	BSC	.100 BSC		
L	13.46	14.10	.530	.555	
L1	_	1.65	_	.065	4
L2	3.56	3.71	.140	.146	

# **TO-262 Part Marking Information**

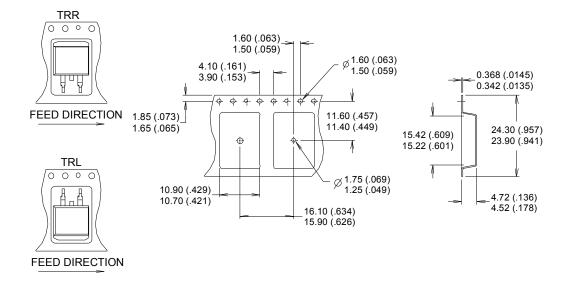


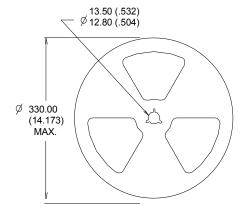
## Notes:

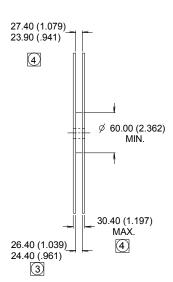
- 1. For an Automotive Qualified version of this part please see http://www.infineon.com/product-info/auto/
- 2. For the most current drawing please refer to Infineon website at <a href="http://www.infineon.com/package/">http://www.infineon.com/package/</a>



# D2-Pak (TO-263AB) Tape & Reel Information (Dimensions are shown in millimeters (inches))







## NOTES:

- COMFORMS TO EIA-418.
  CONTROLLING DIMENSION: MILLIMETER.
- DIMENSION MEASURED @ HUB.
- INCLUDES FLANGE DISTORTION @ OUTER EDGE.

Note: For the most current drawing please refer to IR website at <a href="http://www.irf.com/package/">http://www.irf.com/package/</a>



## Qualification Information<sup>†</sup>

Qualification Level	Industrial (per JEDEC JESD47F) <sup>††</sup>	
Moisture Sensitivity Level	TO-220AB	N/A
	D2-Pak	MSL1 (per JEDEC J-STD-020D) <sup>††</sup>
	TO-262	N/A
RoHS Compliant	Yes	

- † Qualification standards can be found at Infineon's web site <a href="www.infineon.com">www.infineon.com</a>
- †† Applicable version of JEDEC standard at the time of product release.

# **Revision History**

Date	Comments	
5/31/2016	Updated datasheet with corporate template.	
5/31/2010	Added disclaimer on last page.	

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Trademarks updated November 2015

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